

DATA SHEET

74HC1G14; 74HCT1G14 **Inverting Schmitt-triggers**

Product specification
Supersedes data of 2001 Mar 02

2002 May 15

Inverting Schmitt-triggers

74HC1G14; 74HCT1G14

FEATURES

- Wide operating voltage range from 2.0 to 6.0 V
- Symmetrical output impedance
- High noise immunity
- Low power dissipation
- Balanced propagation delays
- Very small 5 pins package
- Applications
 - Wave and pulse shapers
 - Astable multivibrators
 - Monostable multivibrators
- Output capability: standard.

DESCRIPTION

The 74HC1G/HCT1G14 is a high-speed Si-gate CMOS device.

The 74HC1G/HCT1G14 provides the inverting buffer function with Schmitt-trigger action. These devices are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals.

The standard output currents are $\frac{1}{2}$ compared to the 74HC/HCT14.

QUICK REFERENCE DATA

GND = 0 V; $T_{amb} = 25\text{ }^{\circ}\text{C}$; $t_r = t_f = 6.0\text{ ns}$.

SYMBOL	PARAMETER	CONDITIONS	TYPICAL		UNIT
			HC1G	HCT1G	
t_{PHL}/t_{PLH}	propagation delay A to Y	$C_L = 15\text{ pF}$ $V_{CC} = 5\text{ V}$	10	15	ns
C_I	input capacitance		1.5	1.5	pF
C_{PD}	power dissipation capacitance	notes 1 and 2	20	22	pF

Notes

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum (C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

V_{CC} = supply voltage in Volts;

$\sum (C_L \times V_{CC}^2 \times f_o)$ = sum of outputs.

2. For HC1G the condition is $V_I = \text{GND to } V_{CC}$.

For HCT1G the condition is $V_I = \text{GND to } V_{CC} - 1.5\text{ V}$.

FUNCTION TABLE

See note 1.

INPUT	OUTPUT
A	Y
L	H
H	L

Note

1. H = HIGH voltage level;
L = LOW voltage level.

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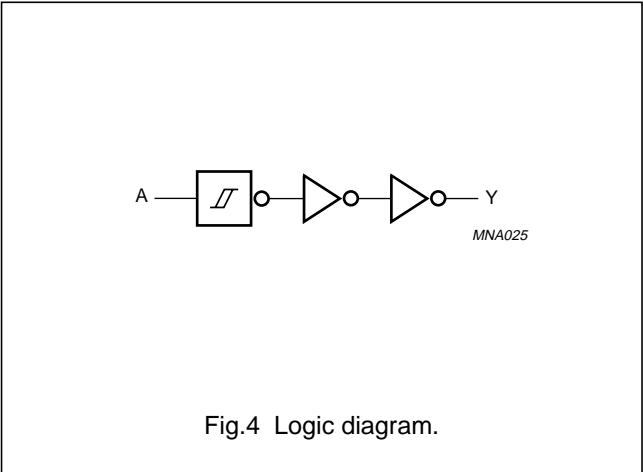
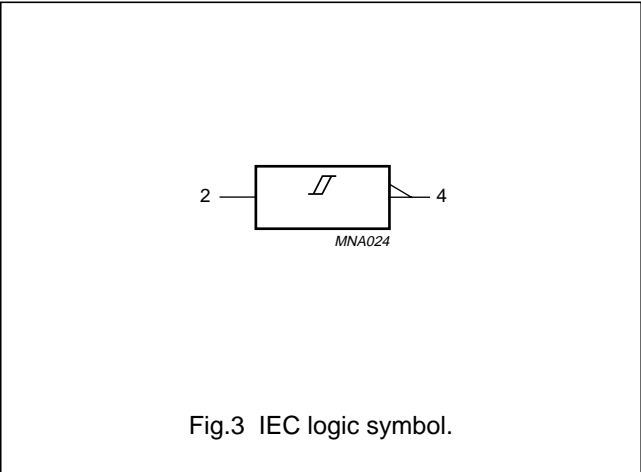
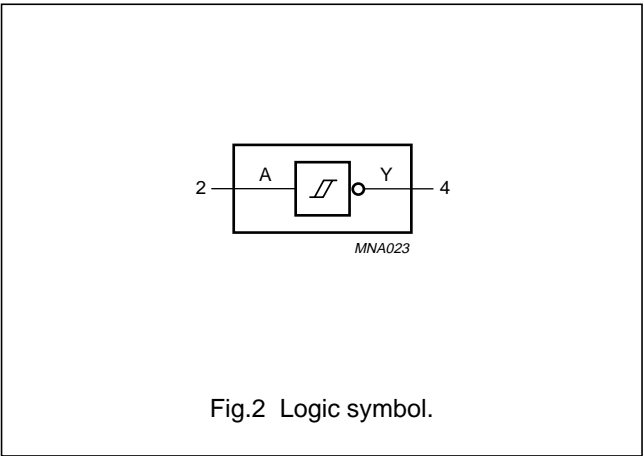
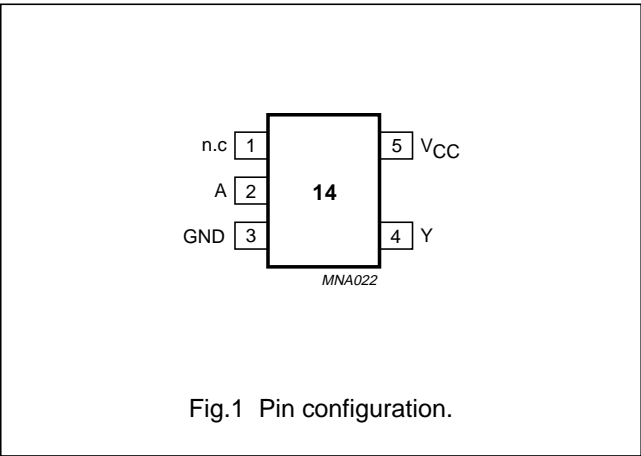
74HC1G14; 74HCT1G14

ORDERING AND PACKAGE INFORMATION

OUTSIDE NORTH AMERICA	PACKAGES					
	TEMPERATURE RANGE	PINS	PACKAGE	MATERIAL	CODE	MARKING
74HC1G14GW	−40 to +125 °C	5	SC-88A	plastic	SOT353	HF
74HCT1G14GW	−40 to +125 °C	5	SC-88A	plastic	SOT353	TF
74HC1G14GV	−40 to +125 °C	5	SC-74A	plastic	SOT753	H14
74HCT1G14GV	−40 to +125 °C	5	SC-74A	plastic	SOT753	T14

PINNING

PIN	SYMBOL	DESCRIPTION
1	n.c.	not connected
2	A	data input A
3	GND	ground (0 V)
4	Y	data output Y
5	V _{CC}	supply voltage



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RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	74HC1G			74HCT1G			UNIT
			MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
V_{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
V_I	input voltage		0	–	V_{CC}	0	–	V_{CC}	V
V_O	output voltage		0	–	V_{CC}	0	–	V_{CC}	V
T_{amb}	operating ambient temperature	see DC and AC characteristics per device	–40	+25	+125	–40	+25	+125	°C

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134); voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CC}	supply voltage		–0.5	+7.0	V
I_{IK}	input diode current	$V_I < -0.5\text{ V}$ or $V_I > V_{CC} + 0.5\text{ V}$; note 1	–	±20	mA
I_{OK}	output diode current	$V_O < -0.5\text{ V}$ or $V_O > V_{CC} + 0.5\text{ V}$; note 1	–	±20	mA
I_O	output source or sink current	$-0.5\text{ V} < V_O < V_{CC} + 0.5\text{ V}$; note 1	–	±12.5	mA
I_{CC}	V_{CC} or GND current	note 1	–	±25	mA
T_{stg}	storage temperature		–65	+150	°C
P_D	power dissipation per package	for temperature range from –40 to +125 °C; note 2	–	200	mW

Notes

1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. Above 55 °C the value of P_D derates linearly with 2.5 mW/K.

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DC CHARACTERISTICS

Family 74HC1G

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} (°C)					UNIT
		OTHER	V _{CC} (V)	–40 to +85			–40 to +125		
				MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
V _{OH}	HIGH-level output voltage	V _I = V _{IH} or V _{IL} ; I _O = –20 μA	2.0	1.9	2.0	–	1.9	–	V
		V _I = V _{IH} or V _{IL} ; I _O = –20 μA	4.5	4.4	4.5	–	4.4	–	V
		V _I = V _{IH} or V _{IL} ; I _O = –20 μA	6.0	5.9	6.0	–	5.9	–	V
		V _I = V _{IH} or V _{IL} ; I _O = –2.0 mA	4.5	4.13	4.32	–	3.7	–	V
		V _I = V _{IH} or V _{IL} ; I _O = –2.6 mA	6.0	5.63	5.81	–	5.2	–	V
V _{OL}	LOW-level output voltage	V _I = V _{IH} or V _{IL} ; I _O = 20 μA	2.0	–	0	0.1	–	0.1	V
		V _I = V _{IH} or V _{IL} ; I _O = 20 μA	4.5	–	0	0.1	–	0.1	V
		V _I = V _{IH} or V _{IL} ; I _O = 20 μA	6.0	–	0	0.1	–	0.1	V
		V _I = V _{IH} or V _{IL} ; I _O = 2.0 mA	4.5	–	0.15	0.33	–	0.4	V
		V _I = V _{IH} or V _{IL} ; I _O = 2.6 mA	6.0	–	0.16	0.33	–	0.4	V
I _{LI}	input leakage current	V _I = V _{CC} or GND	6.0	–	–	1.0	–	1.0	μA
I _{CC}	quiescent supply current	V _I = V _{CC} or GND; I _O = 0	6.0	–	–	10	–	20	μA

Note

1. All typical values are measured at T_{amb} = 25 °C.

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Family 74HC1G14

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} (°C)					UNIT
		WAVEFORMS	V _{CC} (V)	–40 to +85			–40 to +125		
				MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
V _{T+}	positive-going threshold	see Figs 5 and 6	2.0	0.7	1.09	1.5	0.7	1.5	V
			4.5	1.7	2.36	3.15	1.7	3.15	V
			6.0	2.1	3.12	4.2	2.1	4.2	V
V _{T–}	negative-going threshold	see Figs 5 and 6	2.0	0.3	0.60	0.9	0.3	0.9	V
			4.5	0.9	1.53	2.0	0.9	2.0	V
			6.0	1.2	2.08	2.6	1.2	2.6	V
V _H	hysteresis (V _{T+} – V _{T–})	see Figs 5 and 6	2.0	0.2	0.48	1.0	0.2	1.0	V
			4.5	0.4	0.83	1.4	0.4	1.4	V
			6.0	0.6	1.04	1.6	0.6	1.6	V

Note

1. All typical values are measured at T_{amb} = 25 °C.

Family 74HCT1G

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} (°C)					UNIT
		OTHER	V _{CC} (V)	–40 to +85			–40 to +125		
				MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
V _{OH}	HIGH-level output voltage	V _I = V _{IH} or V _{IL} ; I _O = –20 μA	4.5	4.4	4.5	–	4.4	–	V
		V _I = V _{IH} or V _{IL} ; I _O = –2.0 mA	4.5	4.13	4.32	–	3.7	–	V
V _{OL}	LOW-level output voltage	V _I = V _{IH} or V _{IL} ; I _O = 20 μA	4.5	–	0	0.1	–	0.1	V
		V _I = V _{IH} or V _{IL} ; I _O = 2.0 mA	4.5	–	0.15	0.33	–	0.4	V
I _{LI}	input leakage current	V _I = V _{CC} or GND	5.5	–	–	1.0	–	1.0	μA
I _{CC}	quiescent supply current	V _I = V _{CC} or GND; I _O = 0	5.5	–	–	10.0	–	20.0	μA
ΔI _{CC}	additional supply current per input	V _I = V _{CC} – 2.1 V; I _O = 0	4.5 to 5.5	–	–	500	–	850	μA

Note

1. All typical values are measured at T_{amb} = 25 °C.

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Family 74HCT1G14

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} (°C)					UNIT
		WAVEFORMS	V _{CC} (V)	–40 to +85			–40 to +125		
				MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
V _{T+}	positive-going threshold	see Figs 5 and 6	4.5	1.2	1.55	1.9	1.2	1.9	V
			5.5	1.4	1.80	2.1	1.4	2.1	V
V _{T–}	negative-going threshold	see Figs 5 and 6	4.5	0.5	0.76	1.2	0.5	1.2	V
			5.5	0.6	0.90	1.4	0.6	1.4	V
V _H	hysteresis (V _{T+} – V _{T–})	see Figs 5 and 6	4.5	0.4	0.80	–	0.4	–	V
			5.5	0.4	0.90	–	0.4	–	V

Note

1. All typical values are measured at T_{amb} = 25 °C.

AC CHARACTERISTICS

Type 74HC1G14

GND = 0 V; t_r = t_f = 6.0 ns; C_L = 50 pF.

SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} (°C)					UNIT
		WAVEFORMS	V _{CC} (V)	–40 to +85			–40 to +125		
				MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
t _{PHL} /t _{PLH}	propagation delay A to Y	see Figs 12 and 13	2.0	–	25	155	–	190	ns
			4.5	–	12	31	–	38	ns
			6.0	–	11	26	–	32	ns

Note

1. All typical values are measured at T_{amb} = 25 °C.

Type 74HCT1G14

GND = 0 V; t_r = t_f = 6.0 ns; C_L = 50 pF.

SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} (°C)					UNIT
		WAVEFORMS	V _{CC} (V)	−40 to +85			−40 to +125		
				MIN.	TYP. ⁽¹⁾	MAX.	MIN.	MAX.	
t _{PHL} /t _{PLH}	propagation delay A to Y	see Figs 12 and 13	4.5	−	17	43	−	51	ns

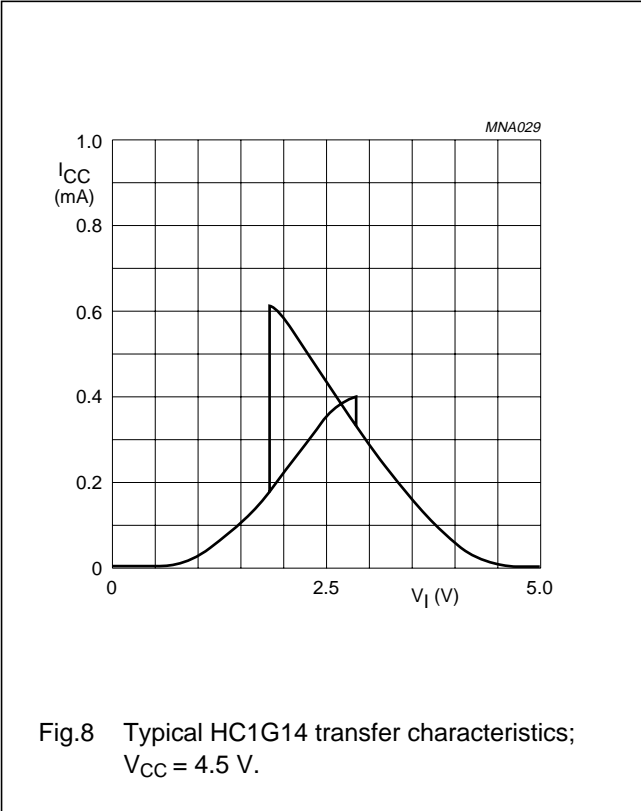
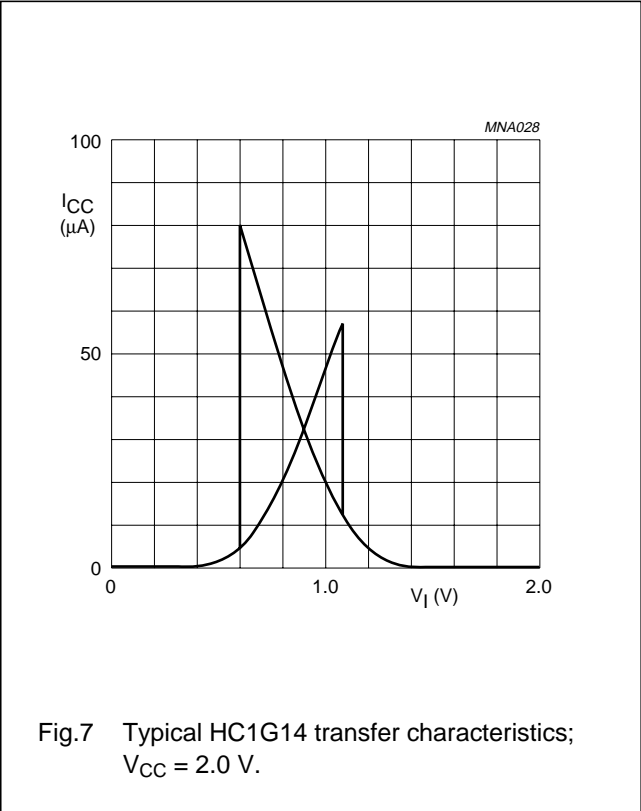
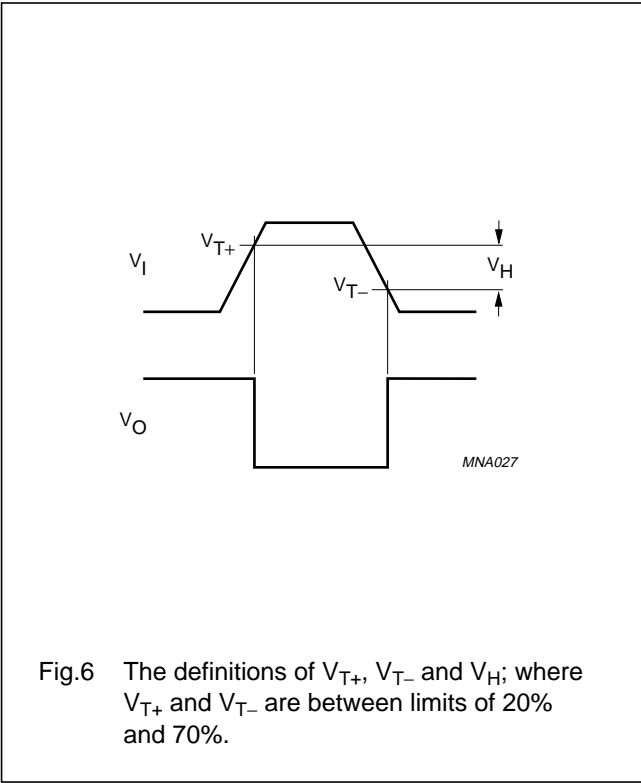
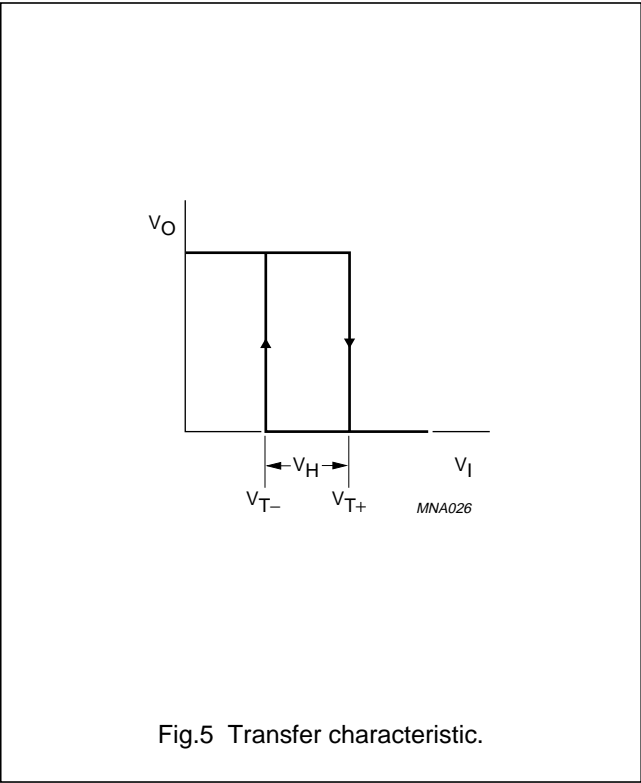
Note

1. All typical values are measured at T_{amb} = 25 °C.

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TRANSFER CHARACTERISTIC WAVEFORMS



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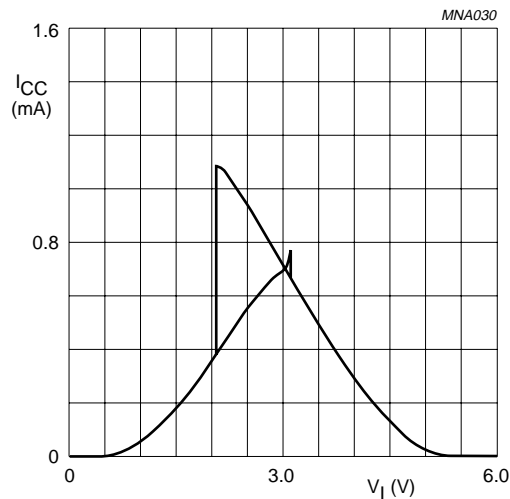


Fig.9 Typical HC1G14 transfer characteristics;
 $V_{CC} = 6.0$ V.

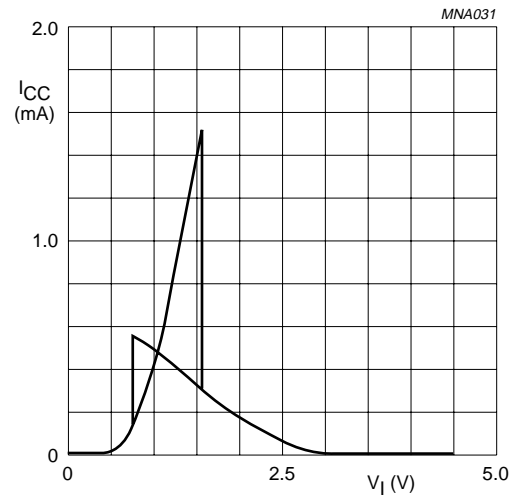


Fig.10 Typical HCT1G14 transfer characteristics;
 $V_{CC} = 4.5$ V.

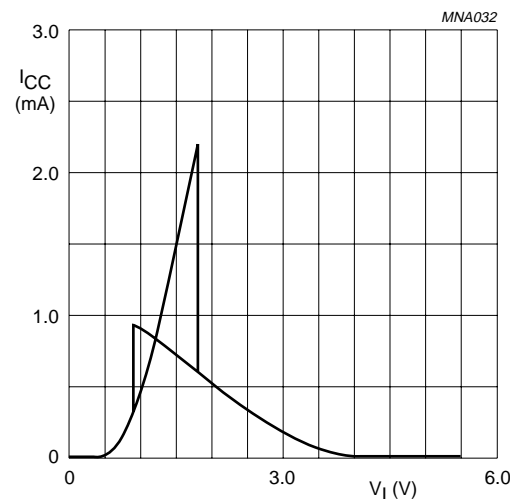
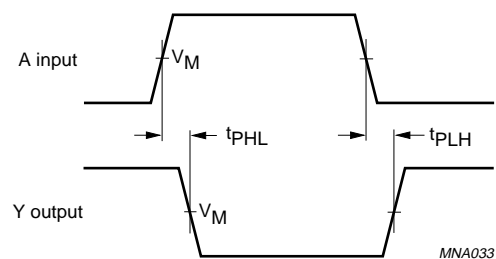


Fig.11 Typical HCT1G14 transfer characteristics;
 $V_{CC} = 5.5$ V.

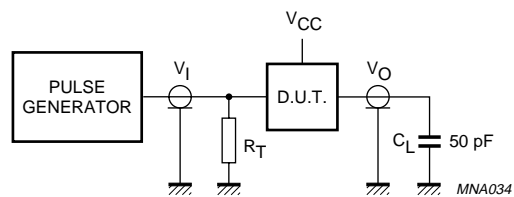


For HC1G: $V_M = 50\%$; $V_I = \text{GND to } V_{CC}$.
For HCT1G: $V_M = 1.3$ V; $V_I = \text{GND to } 3.0$ V.

Fig.12 The input (A) to output (Y) propagation
delays.

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Definitions for test circuit:

C_L = load capacitance including jig and probe capacitance (See "AC characteristics" for values).

R_T = termination resistance should be equal to the output impedance Z_o of the pulse generator.

Fig.13 Load circuitry for switching times.

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APPLICATION INFORMATION

The slow input rise and fall times cause additional power dissipation, this can be calculated using the following formula:

$$P_{ad} = f_i \times (t_r \times I_{CCa} + t_f \times I_{CCa}) \times V_{CC}$$

Where:

P_{ad} = additional power dissipation (μW)

f_i = input frequency (MHz)

t_r = input rise time (ns); 10% to 90%

t_f = input fall time (ns); 90% to 10%

I_{CCa} = average additional supply current (μA).

Average I_{CCa} differs with positive or negative input transitions, as shown in Fig.14 and Fig.15.

HC1G/HCT1G14 used in relaxation oscillator circuit, see Fig.14 and Fig.16.

Note to the application information:

1. All values given are typical unless otherwise specified.

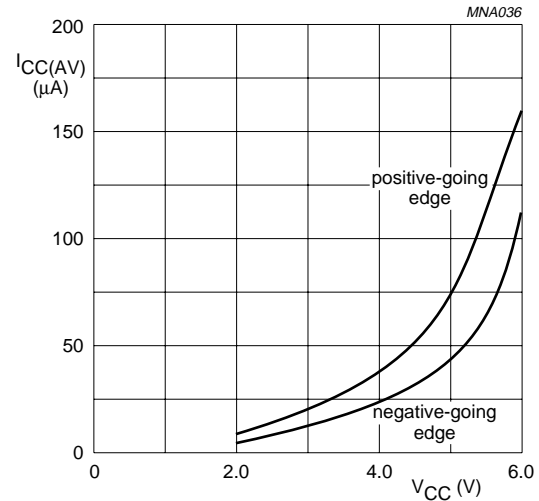


Fig.14 Average I_{CC} for HC1G Schmitt-trigger devices; linear change of V_i between $0.1V_{CC}$ to $0.9V_{CC}$.

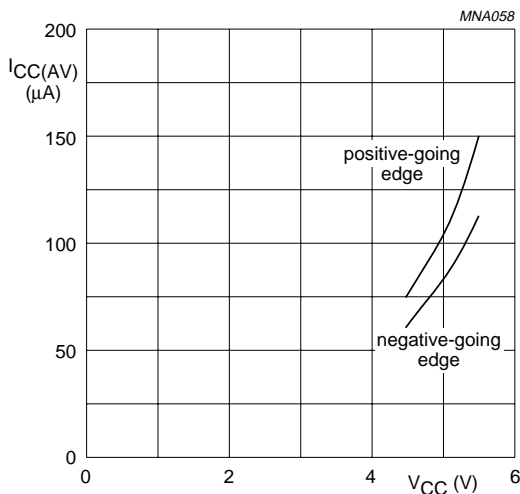
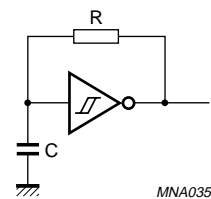


Fig.15 Average I_{CC} for HCT1G Schmitt-trigger devices; linear change of V_i between $0.1V_{CC}$ to $0.9V_{CC}$.



$$\text{For HC1G: } f = \frac{1}{T} \approx \frac{1}{0.8 \times RC}$$

$$\text{For HCT1G: } f = \frac{1}{T} \approx \frac{1}{0.67 \times RC}$$

Fig.16 Relaxation oscillator using the HC1G/HCT1G14.

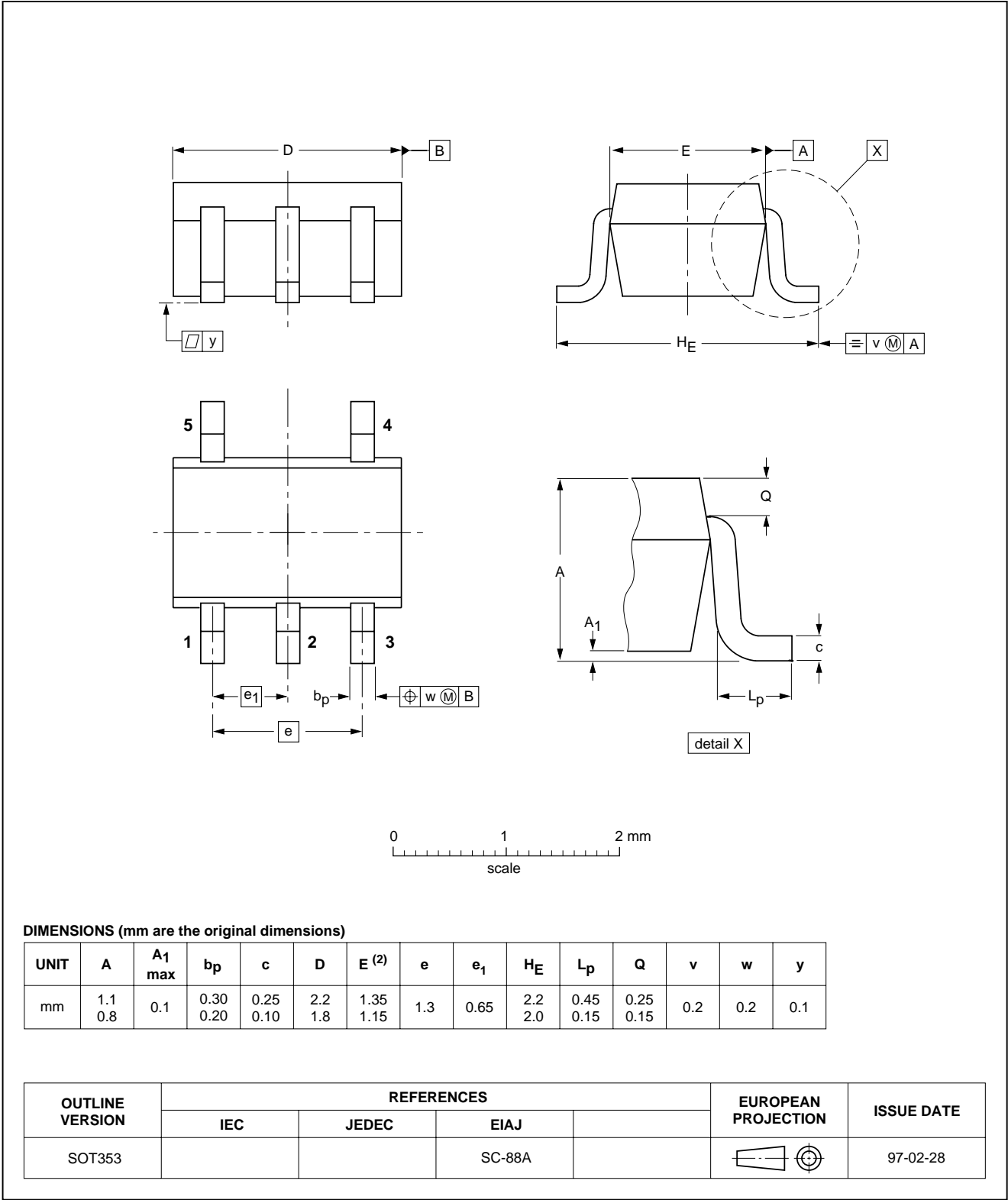
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PACKAGE OUTLINES

Plastic surface mounted package; 5 leads

SOT353

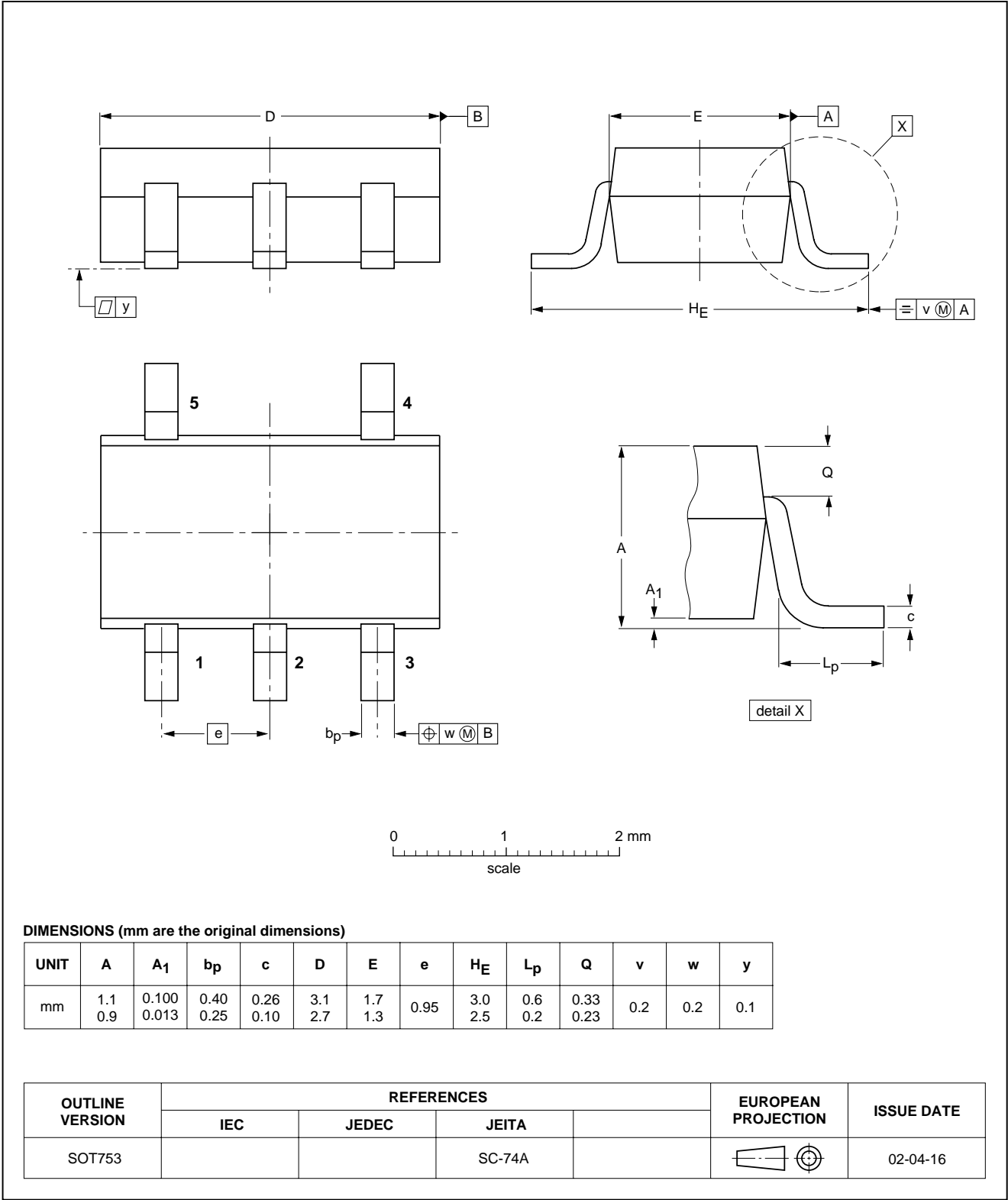


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Plastic surface mounted package; 5 leads

SOT753



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SOLDERING

Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"Data Handbook IC26; Integrated Circuit Packages"* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferably be kept below 220 °C for thick/large packages, and below 235 °C for small/thin packages.

Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
 - larger than or equal to 1.27 mm, the footprint longitudinal axis is **preferred** to be parallel to the transport direction of the printed-circuit board;
 - smaller than 1.27 mm, the footprint longitudinal axis **must** be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

- For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

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Suitability of surface mount IC packages for wave and reflow soldering methods

PACKAGE ⁽¹⁾	SOLDERING METHOD	
	WAVE	REFLOW ⁽²⁾
BGA, LBGA, LFBGA, SQFP, TFBGA, VFBGA	not suitable	suitable
HBCC, HBGA, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, HVQFN, HVSON, SMS	not suitable ⁽³⁾	suitable
PLCC ⁽⁴⁾ , SO, SOJ	suitable	suitable
LQFP, QFP, TQFP	not recommended ⁽⁴⁾⁽⁵⁾	suitable
SSOP, TSSOP, VSO	not recommended ⁽⁶⁾	suitable

Notes

1. For more detailed information on the BGA packages refer to the “(LF)BGA Application Note” (AN01026); order a copy from your Philips Semiconductors sales office.
2. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the “Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods”.
3. These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
4. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
5. Wave soldering is suitable for LQFP, TQFP and QFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
6. Wave soldering is suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

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DATA SHEET STATUS

DATA SHEET STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITIONS
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A.

Notes

1. Please consult the most recently issued data sheet before initiating or completing a design.
2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

DEFINITIONS

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

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Inverting Schmitt-triggers

74HC1G14; 74HCT1G14

NOTES

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